

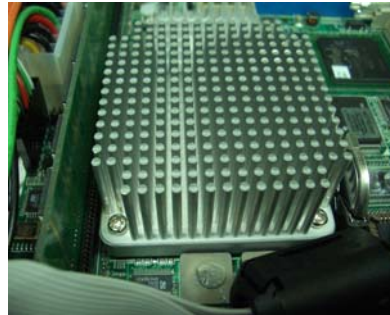
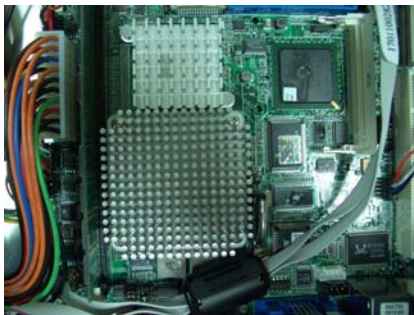
Test item list

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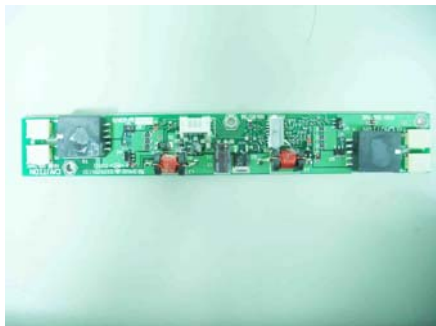
Test Configuration:

Num	Item	Spec
1.	Operator Panel:	AOP-8150WT-A4
	1.LCD	15" CPT TFT-LCD CLAA150XP 03
	2.AC Power	POWER ADD PPS100-31 (71F) (RH)
	4. Inverter	HWA YOUN QF83v3.21
2.	CPU Board:	EMB-852T Rev: A1.1
	1. Bios Ver.	AOP-8150WT-AX BIOS Rev:1.3
	2.CPU	Intel Celeron M Processor 600MHz
	3.Memory	DSL 256MB SAMSUNG K4H560838H-UCB3 (DDR333)
	4. HDD	FUJITSU MHW2040AT / 40GB
	5.Test Software	Windows XP / Run PassMark Burn In Test 5.1 Pro

CPU Heat Sink



Inverter



Temperature cycle test

Test Date: 01-20~23-2008

Test Product: AOP-8150WT-A4

Test Site: AAEON QA Internal Lab.

Performed By: Rex Chang

Test Standard: Reference IEC68-2-14 Testing procedures
Test N: Change of temperature Test

Test Equipment:

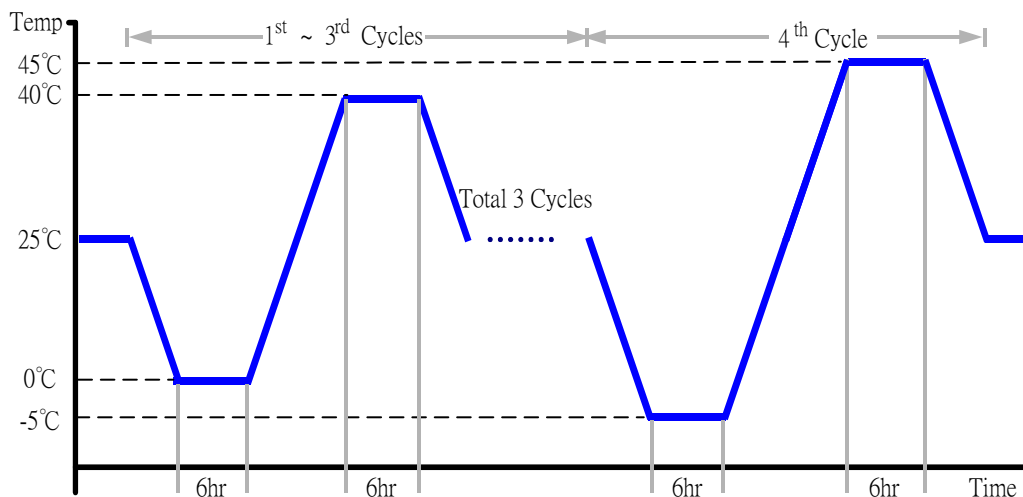
Programmable Temperature & Humidity Chamber
K.SON. INS. TECH. CORP.
Model: THS-D4H+-100
Date of Calibration: 05/16/07
Serial Number: 1241

Temperature Measurement:

40 Channel Thermal Recorder:
YOKOGAWA Inc,
Model: DA100-13-1D
Date of Calibration: 12/13/07
Serial Number: 12A323190

Test Condition:

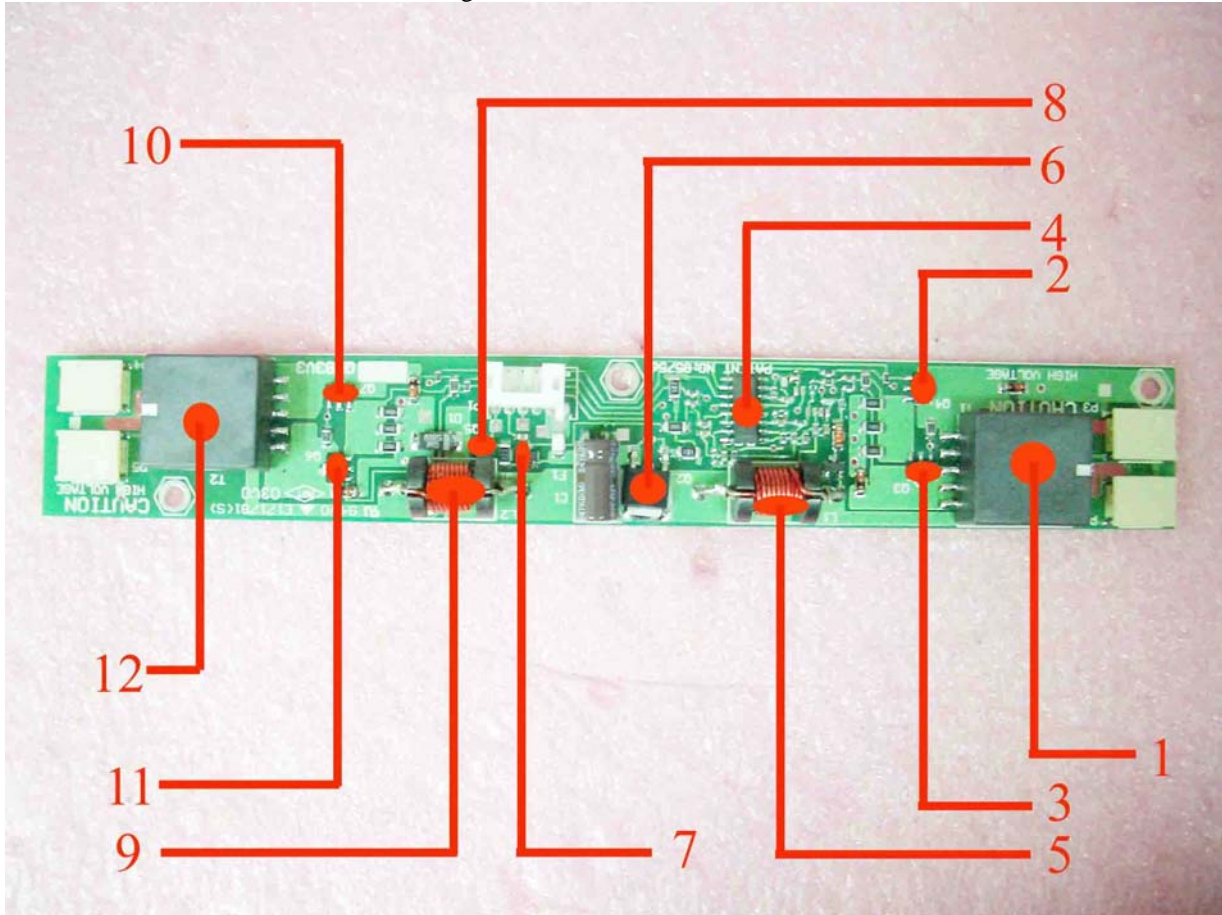
1. Test Low Temperature: 0°C (1~3 cycles)
-5°C (4th cycle)
2. Test High Temperature: 40°C (1~3 cycles)
45°C (4th cycle)
3. Test dwell time: 6Hrs
4. Temperature slope: 2°C/min
5. Test cycle: 4 cycles
6. Test Environment Curve:



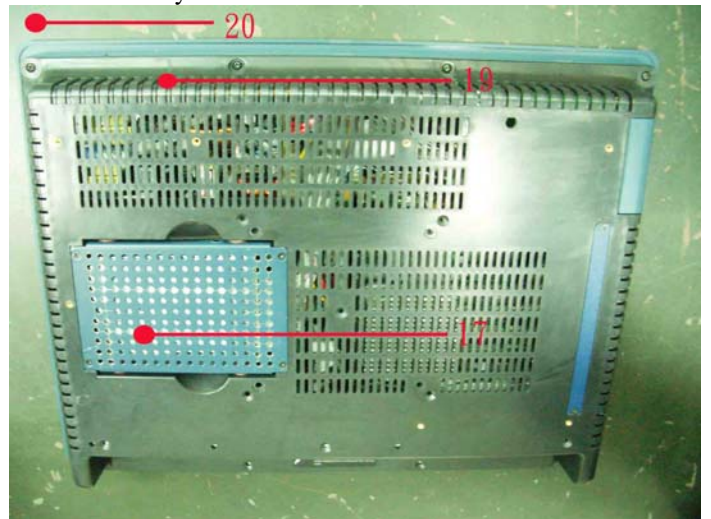
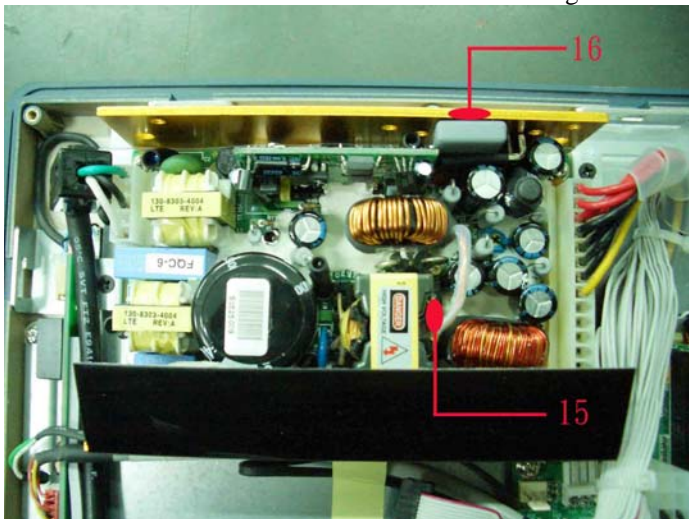
Temperature cycle test

Terminal Recorder:

Measuring Accelerometer Position - Inverter



Measuring Accelerometer Position - System



Temperature cycle test

Thermal profile data:

AOP-8150WT-A4

Point	Temp. Stage(°C)	Spec	40	25	0
Inverter					
1. Inverter - T1		200	81.5	66.5	41.5
2. Inverter - Q4		150	79.9	64.9	39.9
3. Inverter - Q3		150	83.6	68.6	43.6
4. Inverter - IC1		85	81.2	66.2	41.2
5. Inverter - L1		150	86.2	71.2	46.2
6. Inverter - Q2		150	85.3	70.3	45.3
7. Inverter - Q1		150	92.3	77.3	52.3
8. Inverter - Q5		150	91.7	76.7	51.7
9. Inverter - L2		150	80.4	65.4	40.4
10. Inverter - Q7		150	88.3	73.3	48.3
11. Inverter - Q6		150	98.3	83.3	58.3
12. Inverter - T2		200	79.2	64.2	39.2
EMB-852T					
1. U24-Chipset.NB82852GM.Intel.RG82852GM		105	67.7	52.7	27.7
2. U23-INTEL CPU.Celeron-M.ULV 600MHz.		100	66.6	51.6	26.6
3. U25-Chipset ICH4.INTEL.FW82801DB		110	64.1	49.1	24.1
4. U13-2A Bus Termination Regulator.Winbond.W83310S-R2		100	72.4	57.4	32.4
5. U54-ACPI Power Controller.Intersil.ISL6506BCB		100	67.0	52.0	27.0
6. U10-N-Channel.30V.10A.13.5mΩ.MOSFET.APEC.AP4410M		125	69.1	54.1	29.1
7. L2- INDUCTOR.3.3uH.20%. VISHAY.IHLP2525CZRZ3R3M01		125	69.8	54.8	29.8
8. U11-Step-Down DC/DC Controller.Anpec.APW7057		100	68.9	53.9	28.9
9. U57-(TF)RS232 Driver ESD 15KV.INTERASIL.HIN213ECAZ		70	55.6	40.6	15.6
10. U22-CLOCK GENERATOR.ICS.ICS952601		115	67.0	52.0	27.0
11. U45-(TF)RS232 Driver ESD 15KV.INTERASIL.HIN213ECAZ		70	57.9	42.9	17.9
12. U44-(TF)RS232 Driver ESD 15KV.INTERASIL.HIN213ECAZ		70	58.3	43.3	18.3
13. TC25-220uF.2V.Panasonic.EEFSX0D221YR		105	69.2	54.2	29.2
14. TC27-150uF.6.3V.Panasonic.ECGUD0J151R		105	65.4	50.4	25.4
15. Power Supply Heat Sink Surface - 1		N/A	75.7	60.7	35.7
16. Power Supply Heat Sink Surface - 2		N/A	68.7	53.7	28.7
17. HDD		55	55.0	40.0	15.0
18. Memory		70	65.7	50.7	25.7
19. Control Box Surface		N/A	56.1	41.1	16.1
20. Chamber Air Temperature		N/A	40.4	25.4	0.4
Any Tm value showed in red words which meaning the value over the Tc + 5 degree C of this device specification					

Temperature cycle test

Sample Configuration & Quantity Under Test:

Quantity: 1 (AOP-8150WT-A4)

Test Result:

No problem was found during the temperature operation cycle test.

Test Date: 01-28~30-2008

Test Product: AOP-8150WT-A4

Test Site: AAEON QA Internal Lab.

Performed By: Rex Chang

Test Standard: Reference IEC 68-2-2 Testing procedures
Test Bb: Dry Heat Test (Non-operation)

Test Equipment:

Programmable Temperature & Humidity Chamber
K.SON. INS. TECH. CORP.
Model: THS-D4H+-100
Date of Calibration: 05/16/07
Serial Number: 1241

Testing Item:

1. Test Temperature: 60°C
2. Test Times: 48Hrs
3. Test Software: Windows XP / Run PassMark Burn In Test 5.1 Pro
4. Test Environment Curve:



Sample Configuration & Quantity Under Test:

Quantity: 1 (AOP-8150WT-A4)

Test Result:

No problem was found after the high temperature storage test.

Test Date: 01-30-2008~02-01-2008

Test Product: AOP-8150WT-A4

Test Site: AAEON QA Internal Lab.

Performed By: Rex Chang

Test Standard: Reference IEC 68-2-1 Testing procedures
Test Ab: Cold Test (Non-operation)

Test Equipment:

Programmable Temperature & Humidity Chamber
K.SON. INS. TECH. CORP.
Model: THS-D4H+-100
Date of Calibration: 05/16/07
Serial Number: 1241

Testing Item:

1. Test Temperature: -20°C
2. Test Times: 48Hrs
3. Test Software: Windows XP / Run PassMark Burn In Test 5.1 Pro
4. Test Environment Curve:



Sample Configuration & Quantity Under Test:

Quantity: 1 (AOP-8150WT-A4)

Test Result:

No problem was found after the low temperature storage test.

Test Date: 01-25~27-2008

Test Product: AOP-8150WT-A4

Test Site: AAEON QA Internal Lab.

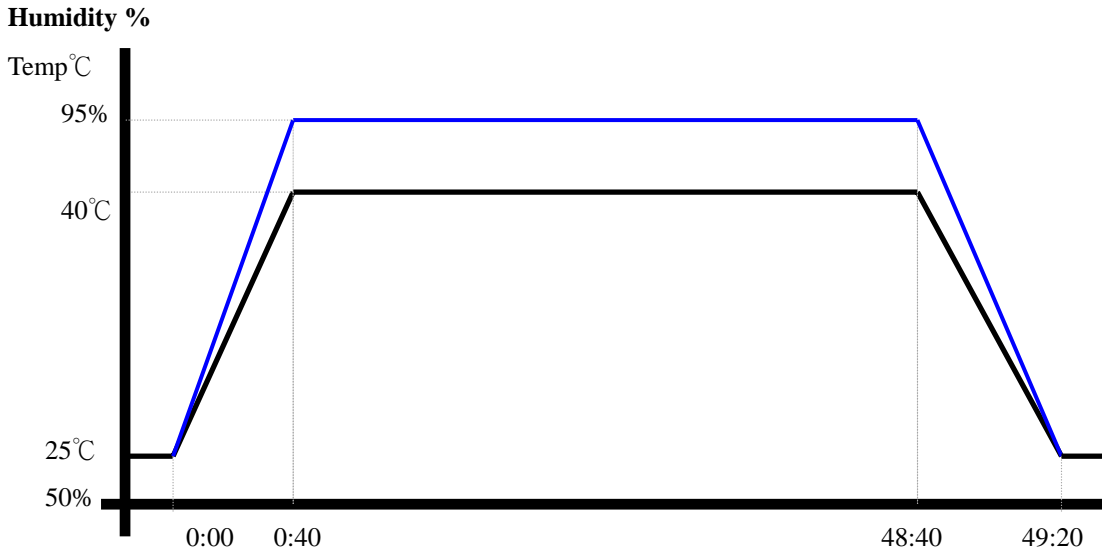
Performed By: Rex Chang

Test Standard: Reference IEC 68-2-3 Testing procedures
Test Ca: Damp heat, steady state (Non-operation)

Test Equipment:
Programmable Temperature & Humidity Chamber
K.SON. INS. TECH. CORP.
Model: THS-D4H+-100
Date of Calibration: 05/16/07
Serial Number: 1241

Testing Item:

1. Test Temperature: 40°C
2. Test Humidity: 95%RH
3. Test Times: 48Hrs
4. Test Software: Windows XP / Run PassMark Burn In Test 5.1 Pro
5. Test Environment Curve:



Sample Configuration & Quantity Under Test:

Quantity: 1 (AOP-8150WT-A4)

Test Result:

No problem was found after the humidity storage test.

Cold start and hot start test

Test Date: 01-23~24-2008

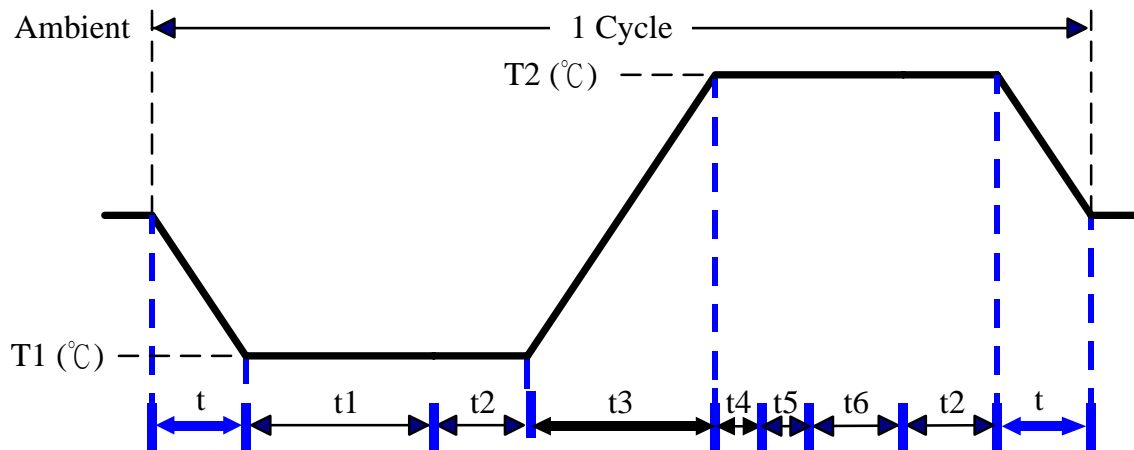
Test Product: AOP-8150WT-A4

Test Site: AAEON QA Internal Lab.

Test Standard: Reference IEC 68-2-14 Testing procedures
Test N: Change of temperature Test

Test Equipment:
Programmable Temperature & Humidity Chamber
K.SON. INS. TECH. CORP.
Model: THS-D4H+-100
Date of Calibration: 05/16/07
Serial Number: 1241

Test Condition:



Parameters	Description
T1	-5°C
T2	45°C
t1	4 hrs
t2, t6	2 hrs
t4, t5	1hrs
t, t3	2°C/min
n (Cycle)	1

t = temprature slope
t , t1, t6: Power Off
t2: Power on/off test 10 times (on 2 min / off 5min)
t3, t4: Run PassMark Burn In Test
t5: Win XP Software restart test 3 times
Test Software: Windows XP

Test Result:

- a. No problem was found during the cold start test.
- b. No problem was found during the hot start test.